Docket No. 242278US2S DIV

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Ryo FUKUDA			C	GAU:	Unassigned
SERIAL NO: New Application			E	EXAMINER:	Unassigned
FILED:	Herewith				
FOR:	SEMICONDUCTOR INT SCANNING	EGRATED CIRCUIT HAVIN	G LATCHI	NG MEANS	CAPABLE OF
		REQUEST FOR PRICE	ORITY		
	IONER FOR PATENTS RIA, VIRGINIA 22313				
SIR:					
	nefit of the filing date of U.S at to the provisions of 35 U.S	. Application Serial Number 09. C. §120.	9/993,603, fi	iled Novembe	er 27, 2001, is claimed
☐ Full ben §119(e)		J.S. Provisional Application(s) Application No.	is claimed p Date F		e provisions of 35 U.S.C.
	nts claim any right to priorit	y from any earlier filed applica noted below.	ations to whi	ch they may	be entitled pursuant to
In the matte	r of the above-identified app	lication for patent, notice is he	reby given t	hat the applic	ants claim as priority:
COUNTRY Japan	<u> </u>	<u>APPLICATION NUMBER</u> 2001-304750		IONTH/DAY eptember 28,	
Certified co	pies of the corresponding Co	onvention Application(s)			
☐ are s	submitted herewith				
□ will	be submitted prior to payme	nt of the Final Fee			
were	e filed in prior application Se	erial No. 09/993,603 filed Nov	ember 27, 2	001	
Rece		nal Bureau in PCT Application of the International Bureau in a se the attached PCT/IB/304.		er under PCT	Rule 17.1(a) has been
□ (A) .	Application Serial No.(s) we	re filed in prior application Ser	rial No.	filed	; and
□ (B) A	Application Serial No.(s)				
are submitted herewith					
	will be submitted prior to	payment of the Final Fee			
			Respectfull	y Submitted,	
Continue	Ntl		,	PIVAK, McC NEUSTADT,	•
Customer			Eckhard H. Kuesters		
228:			Registration No. 28,870		
Tel. (703) 413-3000 Fax. (703) 413-2220			David A. Bilodeau		
(OSMMN 05/03)			Registration No. 42,325		

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